

**Search Notes**

Application/Control No.

10/655,423

Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

JUNG ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
438	696	8/10/2005	BT
438	700	8/10/2005	BT
438	706	8/10/2005	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search inventors' name and keywords using USPAT, USPG-PUB, EPO, JPO, DERWENT databases	8/10/2005	BT
438/697 text only	8/10/2005	BT